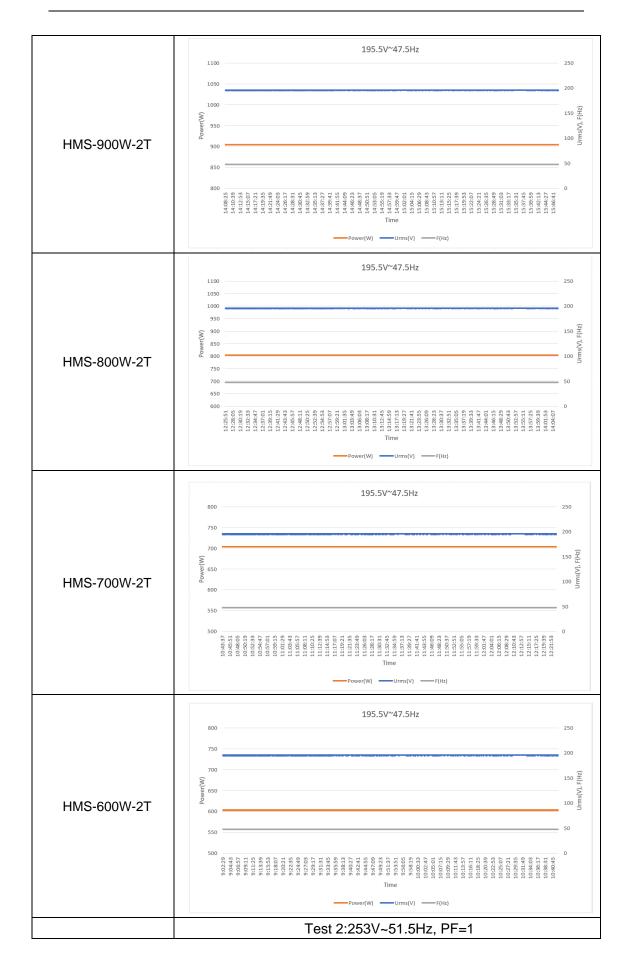
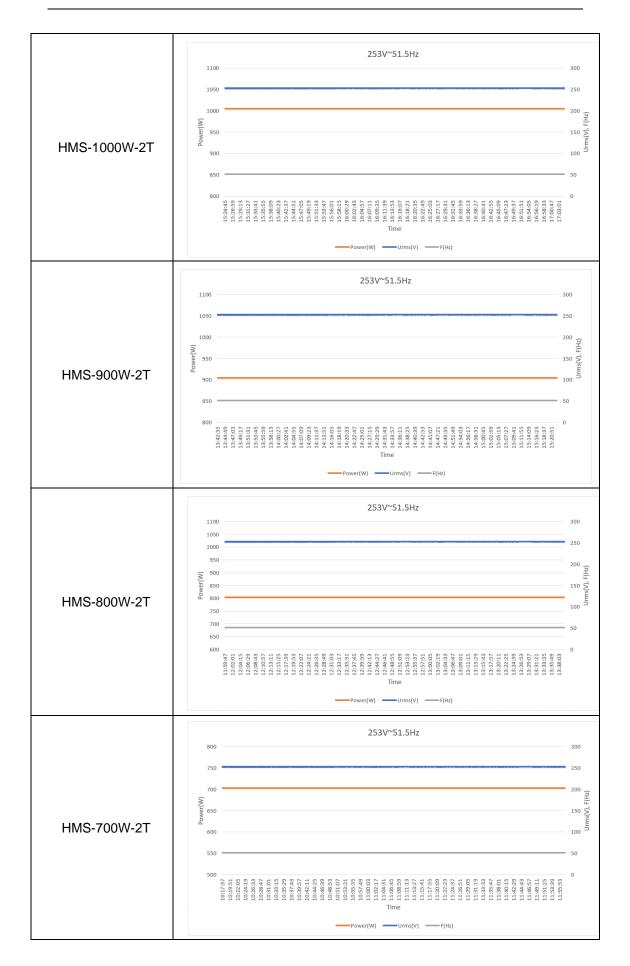
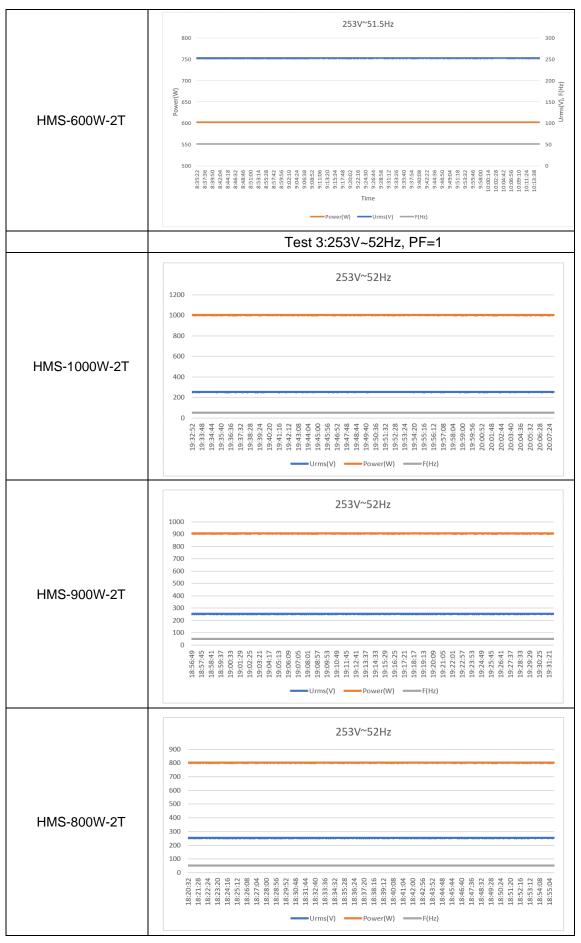
ENA EREC G99/NI						
Type Test reference	e number	HMS-1000\ HMS-700W			V-2T, HMS-800W-2T, -2T	
Generating Unit te	chnology	Photovoltaic Microinverter				
System Supplier na	Hoymiles P	ower E	lectronics	Inc.		
Address	Address			oad, Hang	zhou 310015, China	
Tel	+86 571 2805610	1	Fax		-	
E:mail	info@hoymiles.co	m	Web	site	-	
Registered Capacity, use	1.0/0.9/0.8/0.7/0. 6 per Unit	kW single p	hase, :	single, spli	t or three phase system	
separate sheet if	NA	kW three ph	nase			
more than one	NA	kW two pha	ises in	three phas	se system	
connection option.	NA	kW two phases split phase system				
Manufacturer com	pliance declaration	n I certify tl	hat all	products	supplied by the	
company with the	above Type Teste	d Manufactu	rer's r	eference r	number will be	
manufactured and	I tested to ensure t	hat they per	form a	s stated ir	this document, prior	
to shipment to site	and that no site M	Iodifications	are re	quired to	ensure that the	
product meets all	the requirements c	of EREC G99	9/NI.	•		
Signed	张送骥	On behalf o		Hoymiles	Power Electronics Inc.	
Note that testing c	an be done by the	Manufacture	er of ar	n individua	al component or by an	
external test hous	e.					
Where parts of the	Where parts of the testing are carried out by persons or organizations other than the					
Manufacturer ther	Manufacturer then that person or organization shall keep copies of all test records and					
					d out by people with	
	I competency to ca	0			2	
L						

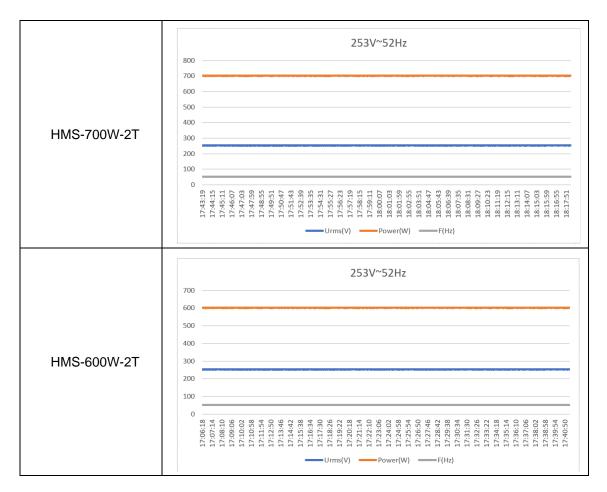
Operating Range Test 1:195.5V~47.5Hz, PF=1 195.5V~47.5Hz 1100 250 1050 200 1000 120 120 Urms(V), F(Hz) Power(W) 950 HMS-1000W-2T 900 50 850 Time Power(W) Urms(V) F(Hz)

ENA EREC G99/NI









	1. Power Quality - Harmonic Generation									
	Generating Unit tested to BS EN 61000-3-12									
					Harmonic %					
Generat	Generating Unit rating per phase (rpp)		1.0	kW	=Measure	ed Value				
(rpp)			1.0	KVV	(Amps) x	23/rating				
					per phase	e (kVA)				
Harmo	Δt 15-55% o	f rated output	100% of r	ated output	Limit ir	BS EN				
nic	At 43-33 % 0		100 % 01 1		6100	0-3-12				
	Measured		Measured							
	Value MV	%	Value MV	%	1 phase	3 phase				
	in Amps	70	in Amps	70	i priase	5 phase				
2	0.0015	0.0345	0.0023	0.0529	8%	8%				
3	0.0054	0.1242	0.0063	0.1449	21.6%	Not				
5					21.070	stated				
4	0.0012	0.0276	0.0009	0.0207	4%	4%				
5	0.0031	0.0713	0.0025	0.0575	10.7%	10.7%				
6	0.0005	0.0115	0.0007	0.0161	2.67%	2.67%				
7	0.0012	0.0276	0.0018	0.0414	7.2%	7.2%				
8	0.0005	0.0115	0.0006	0.0138	2%	2%				
9	0.0013	0.0299	0.0012	0.0276	3.8%	Not				

						stated
10	0.0005	0.0115	0.0005	0.0115	1.6%	1.6%
11	0.0008	0.0184	0.001	0.023	3.1%	3.1%
12	0.0004	0.0092	0.0002	0.0046	1.33%	1.33%
13	0.0005	0.0115	0.0006	0.0138	2%	2%
THD		2.6562		2.8978	23%	13%
PWHD		4.4799		5.5703	23%	22%
		•		•		

2	Pow	ver Quality.	Voltag	e fluctu	ations a	nd Flicke	r	
Test to BS EN 61000-3-11								
	Startin	Starting			ng		Running	
	dmax [%]	dc [%]	d(t) [%]	dmax [%]	dc [%]	d(t) [%]	Pst	Plt 2 hours
Measured Values								
at	0.1	0	0	0.1	0	0	0.066	0.066
test impedance								
Normalised to standard impedance	0.1	0	0	0.1	0	0	0.066	0.066
Normalised to								
required maximum	0.1	0	0	0.1	0	0	0.066	0.066
impedance								
Limits set under BS EN 61000-3-11	4%	3.3%	3.3%	4%	3.3%	3.3%	1	0.65
Test impedance	R	0.4		Ω	XI	0.25		Ω
Standard impedance	R	0.24* 0.4^		Ω	XI	0.15* 0.25^		Ω
Maximum impedance	R	0.4		Ω	ХІ	0.25		Ω
				Test				
Test start date		2023-07	7-24	end		2023	8-07-24	
				date				
Test location							N INSTITU CO., LTD	

3. Power quality. DC injection						
Test power level	10%	55%	100%			
Recorded value(mA)	1.054	3.133	1.895			
as % of rated AC	0.0242	0.0721	0.0436			

current			
Limit	0.25%	0.25%	0.25%

4. Power Quality. Power factor						
	216.2V	230V	253V	Measured at three voltage levels		
Measured value	0.9989	0.9985	0.9978	and at full output. Voltage to be		
Limit (Leading)	>0.95	>0.95	>0.95	maintained within ±1.5% of the		
Limit (Lagging)	>0.98	>0.98	>0.98	stated level during the test.		

	5. Protection. Frequency tests							
Function	Setting		Trip test		"No trip tests"			
	Frequency	Time delay	Frequency	Time delay	Frequency /time	Confirm no trip		
U/F	48Hz	0.5s	48Hz	0.52s	48.2Hz/ 25s	Confirmed		
					47.8Hz/ 0.45s	Confirmed		
O/F	52Hz	1.0s	52Hz	1.02s	51.8Hz/120s	Confirmed		
		52.2Hz/ 0.98s	Confirmed					

	6. Protection. Voltage tests							
Function	Setting Trip tes		est	"No trip	tests"			
	Voltage	Time delay	Voltage	Time delay	Voltage /time	Confirm no trip		
U/V stage 1	195.5V	3s	195.2V	3.02s	199.5V/5s	Confirmed		
U/V stage 2	138V	2s	138.3V	2.02s	142V/2.5s	Confirmed		
					134V/1.95s	Confirmed		
O/V stage 1	253V	0.5s	252.7V	0.52s	249V/5.0s	Confirmed		
		257V/0.45s	Confirmed					

7. Power Park Modules - Protection - Loss of Mains test							
Note: Inverter tested according to BS EN 62116.							
Test Power and 33% 66% 100% 33% 66% 100%							

imbalance	-5% Q	-5% Q	-5% P	+5% Q	+5% Q	+5% P
	Test 22	Test 12	Test 5	Test 31	Test 21	Test 10
Trip time. Limit is 0.5s	91.6ms	183.5ms	243.2ms	94.8ms	181.4ms	246.7ms

8. Loss of Mains Protection, Vector Shift Stability test and RoCoF Stability test							
	Start	Change	End	Confirm no trip			
	Frequency	3-	Frequency				
Positive Vector Shift	49.5Hz	+50 degrees		Confirmed			
Negative Vector Shift	50.5Hz	- 50 degrees		Confirmed			
	Domp rongo	Test frequency	Test	Confirm no trin			
	Ramp range	ramp	Duration	Confirm no trip			
Positive Frequency drift	49Hz to 51Hz	+0.95Hz/sec	2.1s	Confirmed			
Negative Frequency drift	51Hz to 49Hz	-0.95Hz/sec	2.1s	Confirmed			

9.	Limited Frequency	y Sensitive Mode	- Over frequency	test	
Active Power response to rising frequency/time plots are attached if					
frequency injection					
Test sequence	Measured	Frequency	Primary	Active	
at Registered	Active	(Hz)	Power	Power	
Capacity >80	Power Output		Source	Gradient	
%	(W)				
Step a) 50.00Hz	1003.6	50		-	
±0.01Hz	1003.0	50			
Step b) 50.25Hz	992.8	50.25		-	
±0.01Hz	992.0	50.25			
Step c) 50.70Hz	905.3	50.7		-	
±0.10Hz	905.5	50.7			
Step d) 51.15Hz	814.6	51.15		-	
±0.05Hz	014.0	51.15			
Step e) 50.70Hz	903.5	50.7		-	
±0.10Hz	903.5	50.7			
Step f) 50.25Hz	991.7	50.25		-	
±0.05Hz	991.7	50.25			
Step g) 50.00Hz	1002.9	50		-	
±0.01Hz	1002.9	50			
Test sequence	Measured	Frequency	Primary	Active	
at Registered	Active		Power	Power	
Capacity	Power Output		Source	Gradient	
40%~60%					
Step a) 50.00Hz	505.8	50		-	
±0.01Hz	505.8	50			
Step b) 50.25Hz	499.1	50.25		-	
±0.05Hz	433.1	50.25			
Step c) 50.70Hz	456.2	50.7		-	

±0.10Hz		
Step d) 51.15Hz	409.5	51.15
±0.05Hz	409.5	51.15
Step e) 50.70Hz	455.0	50.7
±0.10Hz	455.9	50.7

	10.	Protection. Re	-connection tir	ner	
Test should pro	Test should prove that the reconnection sequence starts in no less than 20s for restoration				for restoration
of voltage and frequency to within the stage 1 settings of table 10.5.7.1					
Time delay	Measured	Checks on no reconnection when voltage or frequency is			frequency is
setting delay		brought to just outside stage 1 limits of table 10.5.7.1.			
60s	60.8s	At 257V	At 191.5V	At 47.9Hz	At 52.1Hz
Confirmation that the Generating Unit does not re-connect.		Confirmed	Confirmed	Confirmed	Confirmed

11. Fault level contribution					
For machines w	or machines with electro-magnetic output For Inver			utput	
Parameter	Symbol	Value	Time after fault	Volts	Amps
Peak Short Circuit current	ip	N/A	20ms	19.12V	0.679A
Initial Value of aperiodic current	A	N/A	100ms	11.67V	0.235A
Initial symmetrical short-circuit current*	lk	N/A	250ms	9.54V	0.186A
Decaying (aperiodic) component of short circuit current*	iDC	N/A	500ms	5.43V	0.153A
Reactance/Re sistance Ratio of source*	X/R	N/A	Time to trip	0.004s	

For rotating machines and linear piston machines the test should produce a 0s - 2s plot of the short circuit current as seen at the Generating Unit terminals.

* Values for these parameters should be provided where the short circuit duration is sufficiently long to enable interpolation of the plot

12. Self-Monitoring solid state switching	Yes/or NA
It has been verified that in the event of the solid state switching device failing to	N/A
disconnect the Generating Unit, the voltage on the output side of the	-

switching device is reduced to a value below 50 Volts within 0.5 seconds	

13. Wiring functional tests: If required by para 15.2.1	Yes/or NA	
Confirm that the relevant test schedule is attached (tests to be undertaken at	N/A	
time of commissioning).	N/A	

14. Logic interface (input port)	Yes/or NA	
Confirm that an input port is provided and can be used to shut down the	Yes	
module.		